

## Advanced Power MOSFET

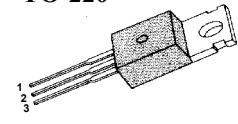
## SSP7N80A

### FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 25  $\mu$ A (Max.) @  $V_{DS} = 800V$
- Low  $R_{DS(ON)}$  : 1.472  $\Omega$  (Typ.)

$BV_{DSS} = 800 V$   
 $R_{DS(on)} = 1.8 \Omega$   
 $I_D = 7 A$

TO-220



1.Gate 2. Drain 3. Source

### Absolute Maximum Ratings

| Symbol         | Characteristic  | Value        | Units         |
|----------------|---|--------------|---------------|
| $V_{DSS}$      | Drain-to-Source Voltage   | 800          | V             |
| $I_D$          | Continuous Drain Current ( $T_C=25^\circ C$ )                           | 7            | A             |
|                | Continuous Drain Current ( $T_C=100^\circ C$ )                          | 4.4          |               |
| $I_{DM}$       | Drain Current-Pulsed ①  | 28           | A             |
| $V_{GS}$       | Gate-to-Source Voltage  | $\pm 30$     | V             |
| $E_{AS}$       | Single Pulsed Avalanche Energy ②  | 523          | mJ            |
| $I_{AR}$       | Avalanche Current ①   | 7            | A             |
| $E_{AR}$       | Repetitive Avalanche Energy ①   | 16           | mJ            |
| $dv/dt$        | Peak Diode Recovery $dv/dt$ ③   | 2.0          | V/ns          |
| $P_D$          | Total Power Dissipation ( $T_C=25^\circ C$ )                            | 160          | W             |
|                | Linear Derating Factor  | 1.28         | $W/W^\circ C$ |
| $T_J, T_{STG}$ | Operating Junction and Storage Temperature Range                        | - 55 to +150 | $^\circ C$    |
| $T_L$          | Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds | 300          |               |

### Thermal Resistance

| Symbol          | Characteristic      | Typ. | Max. | Units        |
|-----------------|---------------------|------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case    | --   | 0.78 | $^\circ C/W$ |
| $R_{\theta CS}$ | Case-to-Sink        | 0.5  | --   |              |
| $R_{\theta JA}$ | Junction-to-Ambient | --   | 62.5 |              |

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## Electrical Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise specified)

| Symbol                            | Characteristic                          | Min. | Typ. | Max. | Units            | Test Condition   |
|-----------------------------------|---|------|------|------|------------------|--|
| $\text{BV}_{\text{DSS}}$          | Drain-Source Breakdown Voltage          | 800  | --   | --   | V                | $\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$  |
| $\Delta \text{BV}/\Delta T_J$     | Breakdown Voltage Temp. Coeff.          | --   | 0.93 | --   | $^\circ\text{C}$ | $\text{I}_D=250\mu\text{A}$ See Fig 7  |
| $\text{V}_{\text{GS}(\text{th})}$ | Gate Threshold Voltage                  | 2.0  | --   | 3.5  | V                | $\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=250\mu\text{A}$  |
| $\text{I}_{\text{GSS}}$           | Gate-Source Leakage , Forward           | --   | --   | 100  | nA               | $\text{V}_{\text{GS}}=30\text{V}$  |
|                                   | Gate-Source Leakage , Reverse           | --   | --   | -100 |                  | $\text{V}_{\text{GS}}=-30\text{V}$   |
| $\text{I}_{\text{DSS}}$           | Drain-to-Source Leakage Current         | --   | --   | 25   | $\mu\text{A}$    | $\text{V}_{\text{DS}}=800\text{V}$   |
|                                   |   | --   | --   | 250  |                  | $\text{V}_{\text{DS}}=640\text{V}, T_C=125^\circ\text{C}$  |
| $\text{R}_{\text{DS}(\text{on})}$ | Static Drain-Source On-State Resistance | --   | --   | 1.8  | $\Omega$         | $\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=0.85\text{A}$ ④*  |
| $\text{g}_{\text{fs}}$            | Forward Transconductance                | --   | 4.95 | --   | $\text{S}$       | $\text{V}_{\text{DS}}=50\text{V}, \text{I}_D=0.85\text{A}$ ④   |
| $\text{C}_{\text{iss}}$           | Input Capacitance                       | --   | 1500 | 1950 | pF               | $\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=25\text{V}, f=1\text{MHz}$<br>See Fig 5                            |
| $\text{C}_{\text{oss}}$           | Output Capacitance                      | --   | 140  | 165  |                  |  |
| $\text{C}_{\text{rss}}$           | Reverse Transfer Capacitance            | --   | 57   | 66   |                  |  |
| $t_{\text{d}(\text{on})}$         | Turn-On Delay Time                      | --   | 23   | 55   | ns               | $\text{V}_{\text{DD}}=400\text{V}, \text{I}_D=2\text{A},$<br>$\text{R}_G=16\Omega$<br>See Fig 13 ④ ⑤                     |
| $t_r$                             | Rise Time                               | --   | 40   | 90   |                  |  |
| $t_{\text{d}(\text{off})}$        | Turn-Off Delay Time                     | --   | 92   | 195  |                  |  |
| $t_f$                             | Fall Time                               | --   | 34   | 80   |                  |  |
| $\text{Q}_g$                      | Total Gate Charge                       | --   | 67   | 88   | nC               | $\text{V}_{\text{DS}}=640\text{V}, \text{V}_{\text{GS}}=10\text{V},$<br>$\text{I}_D=2\text{A}$<br>See Fig 6 & Fig 12 ④ ⑤ |
| $\text{Q}_{\text{gs}}$            | Gate-Source Charge                      | --   | 11.2 | --   |                  |  |
| $\text{Q}_{\text{gd}}$            | Gate-Drain("Miller") Charge             | --   | 29.6 | --   |                  |  |

## Source-Drain Diode Ratings and Characteristics

| Symbol                 | Characteristic            | Min. | Typ. | Max. | Units         | Test Condition   |
|------------------------|---------------------------|------|------|------|---------------|--|
| $\text{I}_S$           | Continuous Source Current | --   | --   | 7    | A             | Integral reverse pn-diode in the MOSFET                                      |
| $\text{I}_{\text{SM}}$ | Pulsed-Source Current ①   | --   | --   | 28   |               |  |
| $\text{V}_{\text{SD}}$ | Diode Forward Voltage ④   | --   | --   | 1.4  | V             | $T_J=25^\circ\text{C}, \text{I}_S=7\text{A}, \text{V}_{\text{GS}}=0\text{V}$ |
| $\text{t}_{\text{rr}}$ | Reverse Recovery Time     | --   | 520  | --   | ns            | $T_J=25^\circ\text{C}, I_F=7\text{A}$<br>$dI_F/dt=100\text{A}/\mu\text{s}$ ④ |
| $\text{Q}_{\text{rr}}$ | Reverse Recovery Charge   | --   | 6.66 | --   | $\mu\text{C}$ |  |

### Notes :

① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature

②  $L=20\text{mH}, \text{I}_{\text{AS}}=7\text{A}, \text{V}_{\text{DD}}=50\text{V}, \text{R}_G=27\Omega$ , Starting  $T_J=25^\circ\text{C}$

③  $\text{I}_{\text{SD}} \leq 7\text{A}, dI/dt \leq 150\text{A}/\mu\text{s}, \text{V}_{\text{DD}} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J=25^\circ\text{C}$

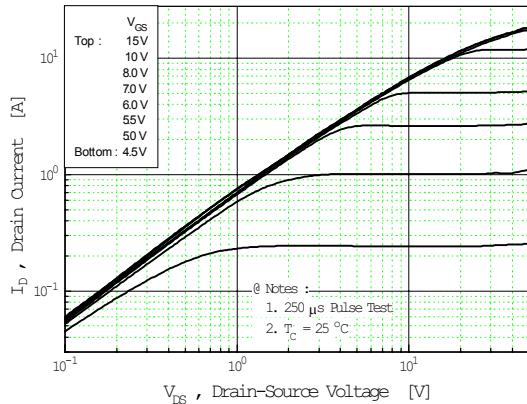
④ Pulse Test : Pulse Width =  $250\mu\text{s}$ , Duty Cycle  $\leq 2\%$

⑤ Essentially Independent of Operating Temperature

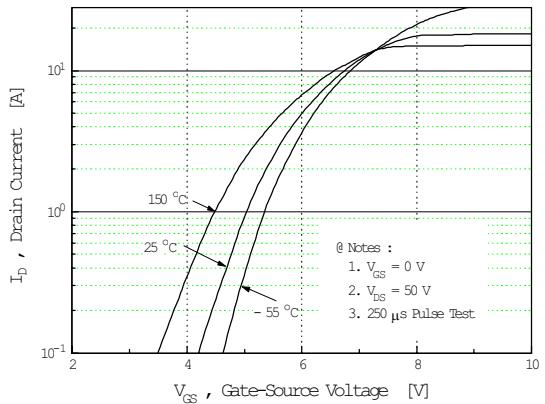
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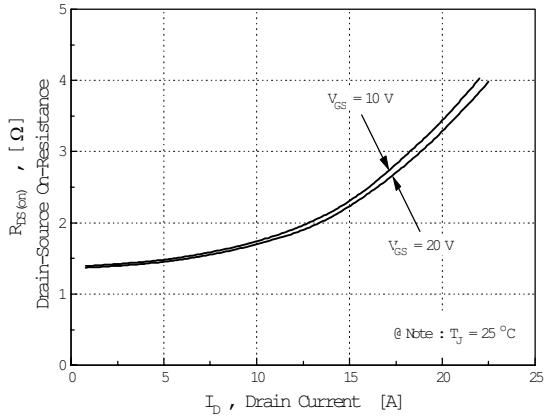
**Fig 1. Output Characteristics**



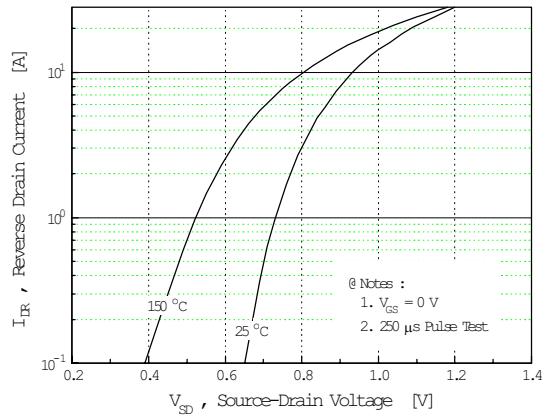
**Fig 2. Transfer Characteristics**



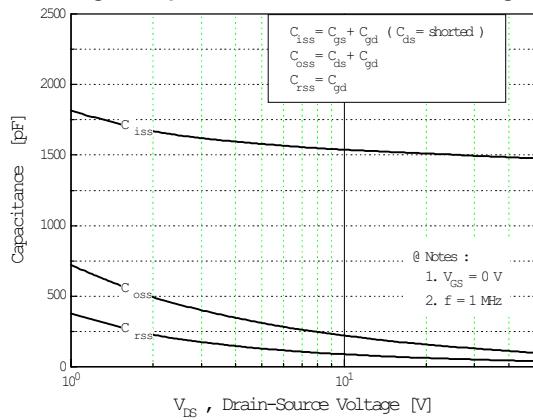
**Fig 3. On-Resistance vs. Drain Current**



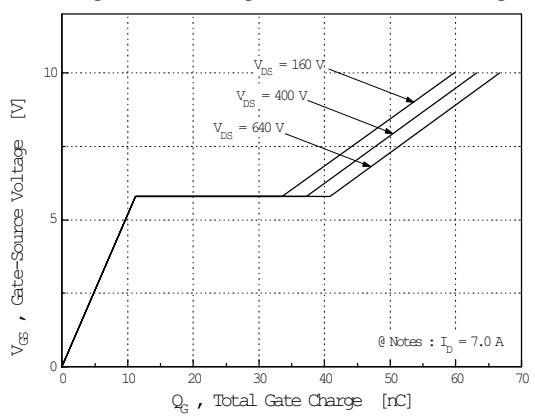
**Fig 4. Source-Drain Diode Forward Voltage**



**Fig 5. Capacitance vs. Drain-Source Voltage**



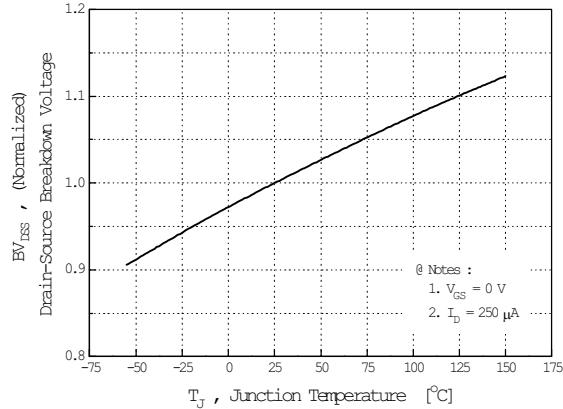
**Fig 6. Gate Charge vs. Gate-Source Voltage**



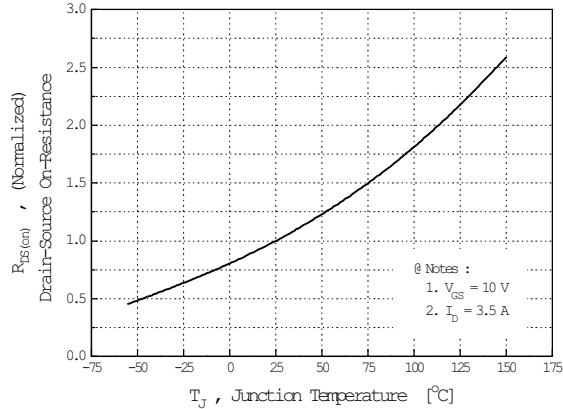
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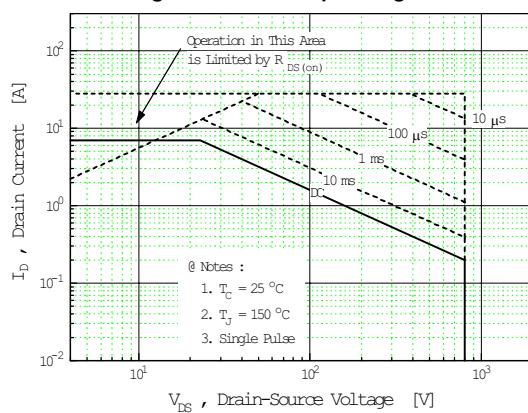
**Fig 7. Breakdown Voltage vs. Temperature**



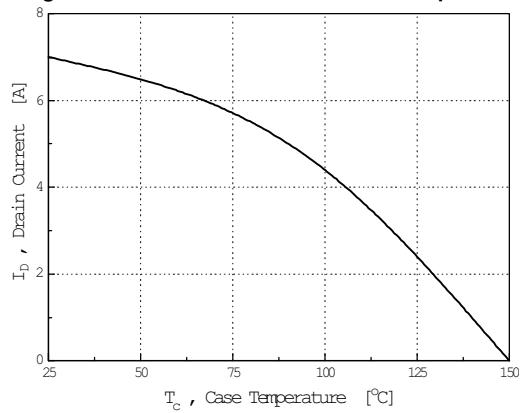
**Fig 8. On-Resistance vs. Temperature**



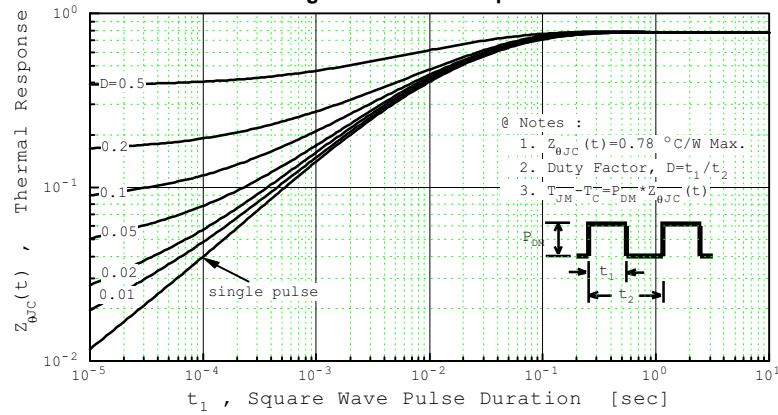
**Fig 9. Max. Safe Operating Area**



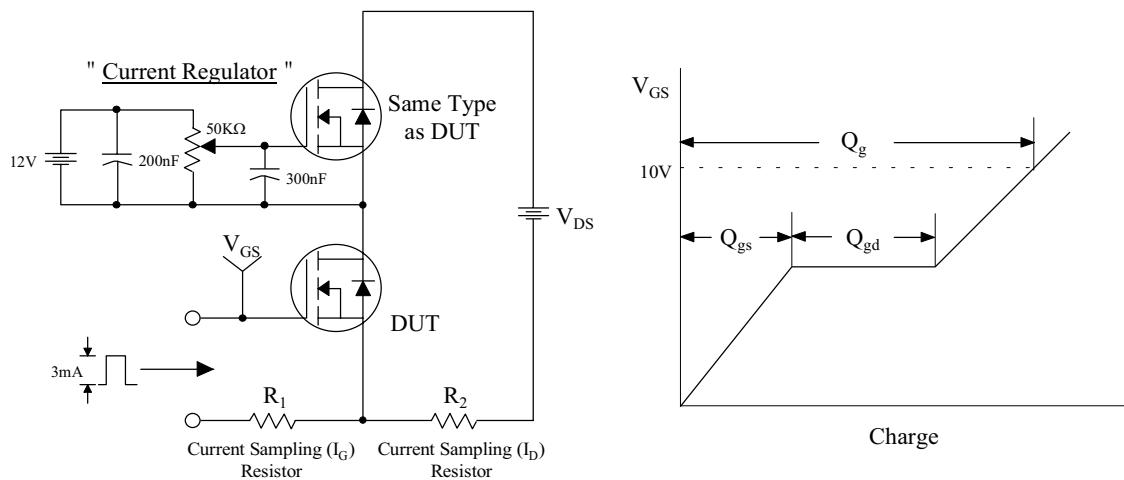
**Fig 10. Max. Drain Current vs. Case Temperature**



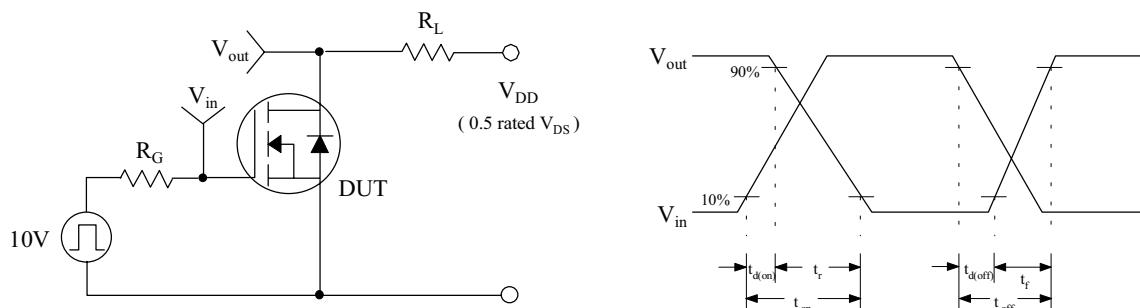
**Fig 11. Thermal Response**



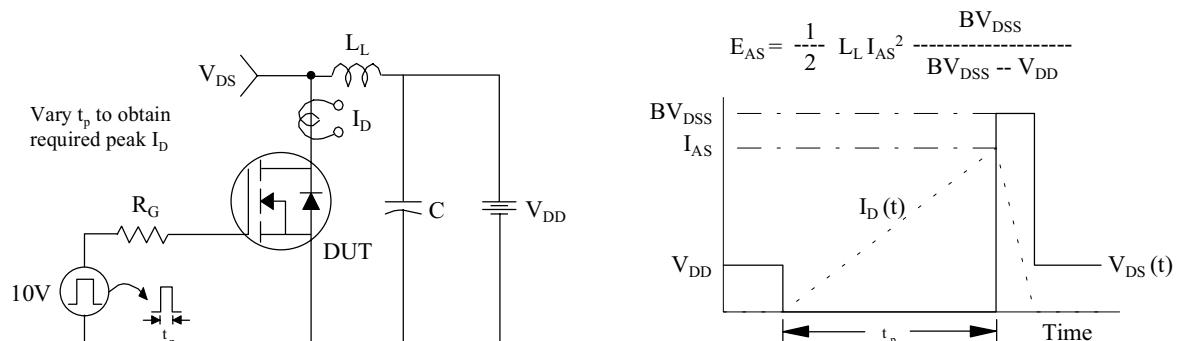
**Fig 12. Gate Charge Test Circuit & Waveform**



**Fig 13. Resistive Switching Test Circuit & Waveforms**



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**



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Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

